

MOSFET – Power, Single N-Channel

40 V, 237 A, 1.2 m Ω

NTMJS1D2N04CL

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- LFPAK8 Package, Industry Standard
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Symbol	Parameter			Value	Unit
V _{DSS}	Drain-to-Source Voltage			40	V
V _{GS}	Gate-to-Source Voltage			±20	V
I _D			T _C = 25°C	237	Α
	Current R _{0JC} (Notes 1, 3)	Steady	T _C = 100°C	168	
P _D	Power Dissipation R ₀ JC (Note 1)	State	T _C = 25°C	128	W
			T _C = 100°C	64	
I _D	Continuous Drain Current R _{0JA} (Notes 1, 2, 3)	Steady State	T _A = 25°C	41	Α
			T _A = 100°C	29	
P_{D}	Power Dissipation R _{0JA} (Notes 1, 2)		T _A = 25°C	3.8	W
			T _A = 100°C	1.9	
I _{DM}	Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	1480	Α
T _J , T _{stg}	Operating Junction and Storage Temperature Range			–55 to + 175	°C
I _S	Source Current (Body Diode)			107	Α
E _{AS}	Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 19 A)			453	mJ
TL	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

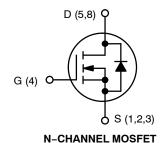
Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Junction-to-Case - Steady State	1.2	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State (Note 2)	36	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

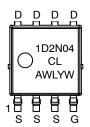
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
40 V	1.2 m Ω @ 10 V	007.4	
	1.8 mΩ @ 4.5 V	237 A	



LFPAK8 CASE 760AA



MARKING DIAGRAM



1D2N04CL = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition		Min	Тур	Max	Unit	
OFF CHAR	ACTERISTICS	•						
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	V _{GS} = 0 V, I _D =	250 μΑ	40			V	
V _{(BR)DSS} /	Drain-to-Source Breakdown Voltage Temperature Coefficient				20		mV/°C	
I _{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0 V$	T _J = 25°C			10	^	
		V _{DS} = 40 V	T _J = 125°C			250	μΑ	
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS}	s = 20 V			100	nA	
ON CHARA	CTERISTICS (Note 6)							
V _{GS(TH)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D =$	$V_{GS} = V_{DS}, I_D = 170 \mu A$			2.0	V	
V _{GS(TH)} /T _J	Threshold Temperature Coefficient				-5.9		mV/°C	
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 4.5 V	I _D = 50 A		1.5	1.8	mΩ	
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 10 V	I _D = 50 A		1	1.2	mΩ	
9FS	Forward Transconductance	V _{DS} = 10 V, I _D	= 50 A		190		S	
CHARGES,	CAPACITANCES & GATE RESISTANCE						-	
C _{ISS}	Input Capacitance			5600		pF		
C _{OSS}	Output Capacitance	V _{GS} = 0 V, f = 1 MH:		2600				
C _{RSS}	Reverse Transfer Capacitance			70				
Q _{G(TOT)}	Total Gate Charge	V _{GS} = 4.5 V, V _{DS} = 20 V; I _D = 50 A			44		nC	
Q _{G(TOT)}	Total Gate Charge	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 50 A			93			
Q _{G(TH)}	Threshold Gate Charge	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 50 A			9.4		nC	
Q _{GS}	Gate-to-Source Charge				17.2			
Q_{GD}	Gate-to-Drain Charge				13.6			
V _{GP}	Plateau Voltage				3.1		V	
SWITCHING	CHARACTERISTICS (Note 7)						-	
t _{d(ON)}	Turn-On Delay Time				24			
t _r	Rise Time	V _{GS} = 10 V, V _{DS}	s = 20 V.		72		1	
t _{d(OFF)}	Turn-Off Delay Time	I _D = 50 A, R _G	$I_D = 50 \text{ A}, R_G = 2.5 \Omega$		122		ns	
t _f	Fall Time	1			116		1	
DRAIN-SO	URCE DIODE CHARACTERISTICS				-		-	
V _{SD}	Forward Diode Voltage	V _{GS} = 0 V,	T _J = 25°C		0.76	1.2	V	
		I _S = 50 A	T _J = 125°C		0.66			
t _{RR}	Reverse Recovery Time	 			59			
ta	Charge Time	$V_{GS} = 0 \text{ V, dIS/dt}$	= 100 A/us.		29		ns	
t _b	Discharge Time	I _S = 50 A			30			
Q _{RR}	Reverse Recovery Charge		-		43		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

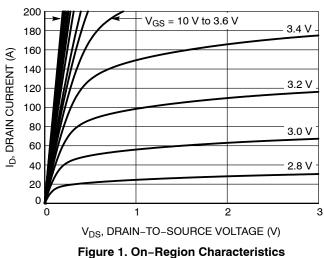
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

^{6.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

^{7.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



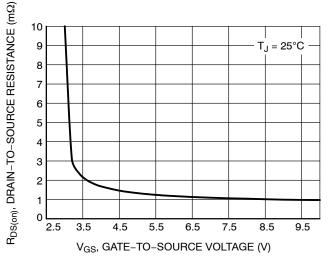


Figure 3. On-Resistance vs. Gate-to-Source Voltage

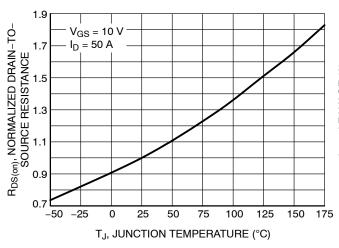


Figure 5. On-Resistance Variation with **Temperature**

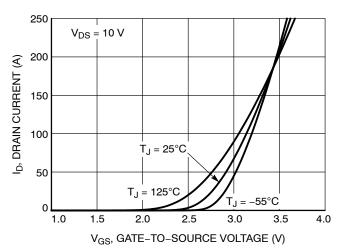


Figure 2. Transfer Characteristics

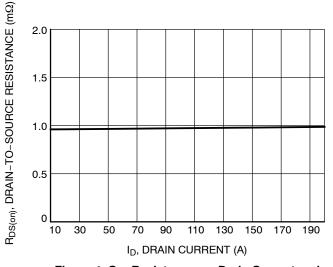


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

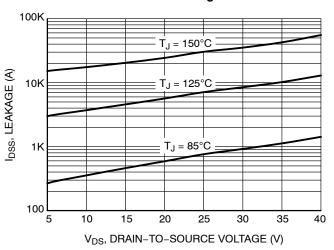


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS (coninued)

Is, SOURCE CURRENT (A)

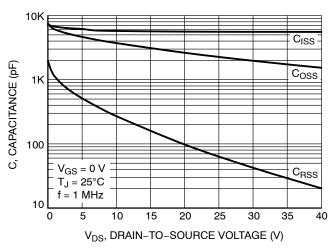


Figure 7. Capacitance Variation

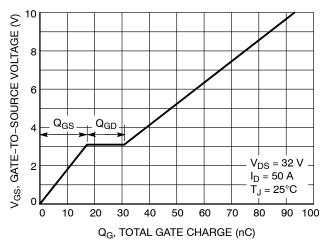


Figure 8. Gate-to-Source Voltage vs. Total Charge

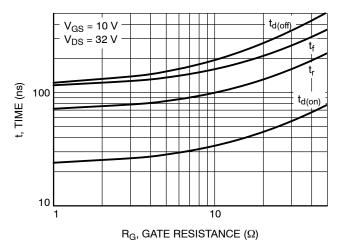


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

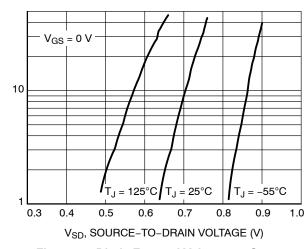


Figure 10. Diode Forward Voltage vs. Current

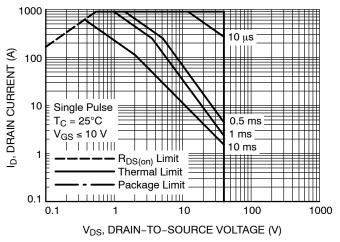


Figure 11. Maximum Rated Forward Biased Safe Operating Area

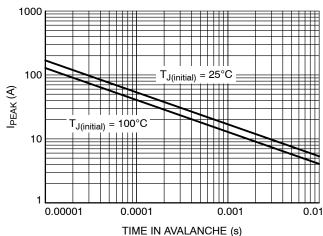


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS (coninued)

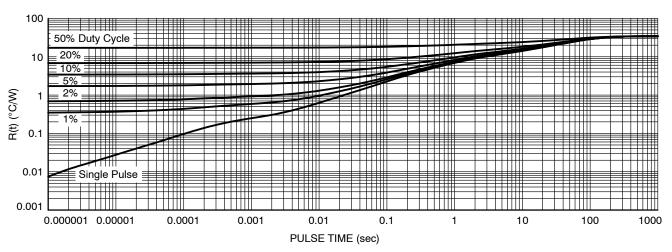


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMJS1D2N04CLTWG	1D2N04 CL	LFPAK8 (Pb-Free)	3,000 / Tape & Reel

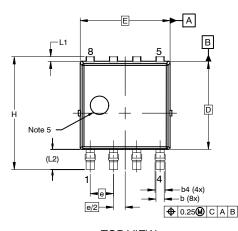
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

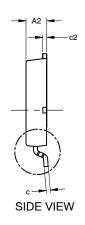




LFPAK8 4.90x4.80x1.12MM, 1.27PCASE 760AA ISSUE D

DATE 22 APR 2024

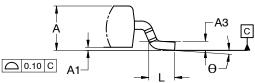


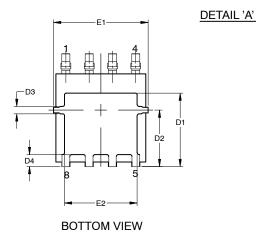


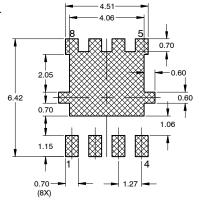
NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. OPTIONAL MOLD FEATURE.









RECOMMENDED LAND PAD

*FOR ADDITIONAL INFORMATION ON OUR

PB-FREE STRATEGY AND SOLDERING DETAILS.

PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE

MILLIMETERS MIN NOM DIM 1.10 1.20 1.30 Α A1 0.00 0.08 0.15 A2 1.10 1.15 1.20 АЗ 0.25 BSC b 0.40 0.45 0.50 0.45 0.55 0.65 b4 0.19 0.22 0.25 С c2 0.19 0.22 0.25 4.70 4.80 4.90 D D1 3.80 4.00 4.20 2.98 D2 3.08 3.18 D3 0.30 0.40 0.50 D4 0.55 0.65 0.75 4.80 4.90 5.00 Ε E1 5.05 5.15 5.25 E2 3.91 3.96 4.01 1.27 BSC е 0.635 BSC e/2 Н 6.00 6.15 6.30 L 0.50 0.70 0.90 0.25 0.35 L1 0.15 L2 1.10 REF 4° θ

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

A = Assembly Location

WL = Wafer Lot
 Y = Year
 W = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking.

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